



**PATENT APPLICATION**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re application of

Docket No: 005329 USA Y1/MASK/RT/OR

Shirley HEMAR, et al.

Appln. No.: 09/876,955

Group Art Unit: 2625

Confirmation No.: 4359

Examiner: John B. STREGE

Filed: June 7, 2001

For: ALTERNATING PHASE-SHIFT MASK INSPECTION METHOD AND APPARATUS

**INFORMATION DISCLOSURE STATEMENT**  
**UNDER 37 C.F.R. §§ 1.97 and 1.98**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure under 37 C.F.R. § 1.56, Applicant hereby notifies the U.S. Patent and Trademark Office of the documents which are listed on the attached PTO/SB/08 A & B (modified) form and/or listed herein and which the Examiner may deem material to patentability of the claims of the above-identified application.

One copy of each of the listed documents is submitted herewith, except for the following: U.S. patents and/or U.S. patent publications; and co-pending non-provisional U.S. applications filed after June 30, 2003.

The present Information Disclosure Statement is being filed (without a Statement Under 37 C.F.R. § 1.97(e)) after the later of three months from the application's filing date and the mailing date of the first Office Action on the merits, but before a Final Office Action, Notice of Allowance, or an action that otherwise closes prosecution in the application (whichever is


**INFORMATION DISCLOSURE STATEMENT**  
U.S. Appln. No.: 09/876,955

earlier), and therefore please charge the fee of \$180.00 under 37 C.F.R. § 1.17(p) to Deposit Account No. 19-4880.

The submission of the listed documents is not intended as an admission that any such document constitutes prior art against the claims of the present application. Applicant does not waive any right to take any action that would be appropriate to antedate or otherwise remove any listed document as a competent reference against the claims of the present application.

The USPTO is directed and authorized to charge all required fees, except for the Issue Fee and the Publication Fee, to Deposit Account No. 19-4880. Please also credit any overpayments to said Deposit Account. A duplicate copy of this paper is attached.

Respectfully submitted,

  
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Substitute for Form 1449-A & B/PTO

# **INFORMATION DISCLOSURE STATEMENT BY APPLICANT**

(use as many sheets as necessary)

Sheet

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of

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Complete if Known

Application Number	09/876,955
Confirmation Number	4359
Filing Date	June 7, 2001
First Named Inventor	Shirley HEMAR
Art Unit	2625
Examiner Name	John B. STREGE
Attorney Docket Number	005329 USA Y1/MASK/RT/OR

## **U.S. PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Document Number		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		Number	Kind Code <sup>2</sup> (if known)		
		US 5,838,433		11-17-1998	Hagiwara
		US 5,563,702		10-08-1996	Emery et al.
		US 3,725,574		04-03-1973	Gast
		US 4,926,489		05-15-1990	Danielson et al.
		US 5,210,635		05-11-1993	Nagata et al.
		US 4,595,289		06-17-1986	Feldman et al.
		US 5,892,579		04-06-1999	Elyasaf et al.
		US 6,124,924		09-26-2000	Feldman et al.
		US 6,466,315		10-15-2002	Karpol et al.
		US			
		US			

## **FOREIGN PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document			Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Translation <sup>6</sup>
		Country Code <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup> (if known)			

## **NON PATENT LITERATURE DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.	Translation <sup>6</sup>
		FERGUSON, RICHARD A., ET AL., "Application of an Aerial Image Measurement System to Mask Fabrication and Analysis," SPIE Vol. 2087 13 <sup>th</sup> Annual Symposium on Photomask Technology and Management, Sept. 22-23, 1993, Santa Clara, California, pp. 131-144.	

Examiner Signature

Date Considered